Silicon P Channel Power MOS FET High Speed Power Switching

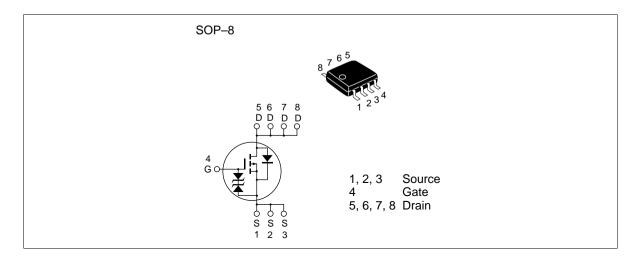
HITACHI

ADE-208-436 G (Z) 8th. Edition June 1997

Features

- Low on-resistance
- Capable of 2.5 V gate drive
- Low drive current
- High density mounting

Outline





Absolute Maximum Ratings ($Ta = 25^{\circ}C$)

Item	Symbol	Ratings	Unit
Drain to source voltage	$V_{ exttt{DSS}}$	-20	V
Gate to source voltage	V _{GSS}	±10	V
Drain current	I _D	- 7	A
Drain peak current	Note1 D(pulse)	- 56	A
Body-drain diode reverse drain current	I _{DR}	- 7	A
Channel dissipation	Pch Note2	2.5	W
Channel temperature	Tch	150	°C
Storage temperature	Tstg	-55 to +150	°C

Note:

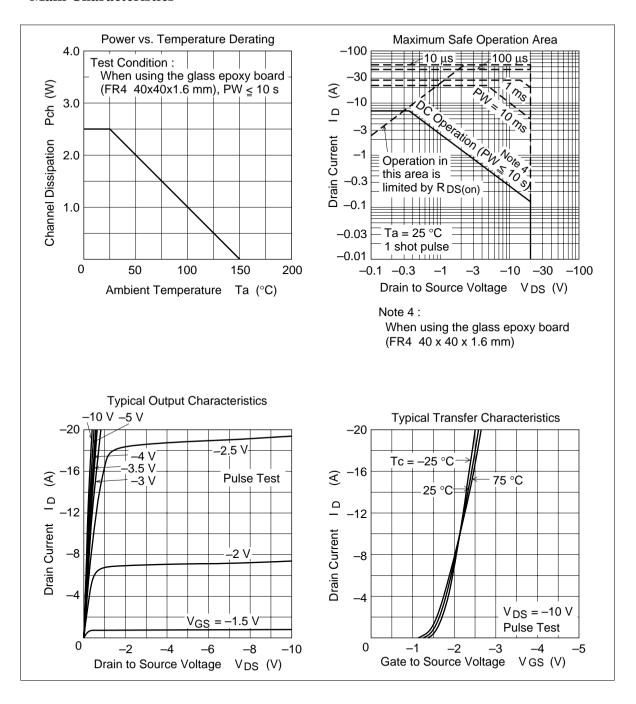
- 1. PW \leq 10 μ s, duty cycle \leq 1 %
- 2. When using the glass epoxy board (FR4 40 x 40 x 1.6 mm), PW \leq 10s

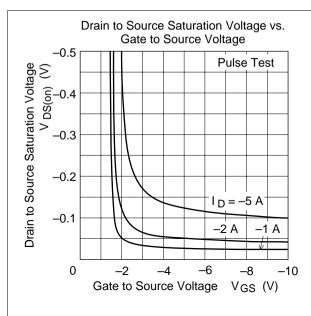
Electrical Characteristics ($Ta = 25^{\circ}C$)

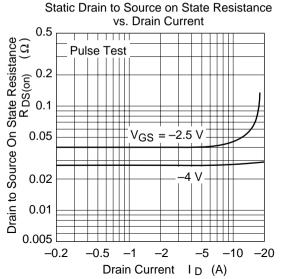
Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	-20	_	_	V	$I_{D} = -10 \text{mA}, V_{GS} = 0$
Gate to source breakdown voltage	$V_{(BR)GSS}$	±10	_	_	V	$I_G = \pm 100 \mu A, V_{DS} = 0$
Gate to source leak current	$I_{\rm GSS}$	_	_	±10	μΑ	$V_{GS} = \pm 8V$, $V_{DS} = 0$
Zero gate voltege drain current	I _{DSS}	_	_	-10	μΑ	$V_{DS} = -20 \text{ V}, V_{GS} = 0$
Gate to source cutoff voltage	$V_{\text{GS(off)}}$	-0.5	_	-1.5	V	$V_{DS} = -10V, I_{D} = -1mA$
Static drain to source on state	$R_{\scriptscriptstyle DS(on)}$	_	0.027	0.04	Ω	$I_{\rm D} = -4{\rm A},\ V_{\rm GS} = -4{\rm V}^{\rm Note3}$
resistance	R _{DS(on)}	_	0.04	0.06	Ω	$I_D = -4A, V_{GS} = -2.5V^{Note3}$
Forward transfer admittance	y _{fs}	9	14	_	S	$I_{D} = -4A, V_{DS} = -10V^{Note3}$
Input capacitance	Ciss	_	2250	_	pF	$V_{DS} = -10V$
Output capacitance	Coss	_	1120	_	pF	$V_{GS} = 0$
Reverse transfer capacitance	Crss	_	300	_	pF	f = 1MHz
Turn-on delay time	$t_{d(on)}$	_	40	_	ns	$V_{GS} = -4V$, $I_D = -4A$
Rise time	t _r	_	200	_	ns	$V_{DD} \cong -10V$
Turn-off delay time	t _{d(off)}	_	280	_	ns	_
Fall time	t _f	_	220	_	ns	_
Body-drain diode forward voltage	V_{DF}	_	-0.9	-1.4	V	$IF = -7A$, $V_{GS} = 0$ Note3
Body-drain diode reverse recovery time	t _{rr}	_	75	_	ns	IF = -7A, $V_{GS} = 0$ diF/ dt =20A/ μ s

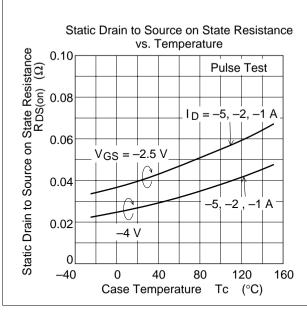
Note: 3. Pulse test

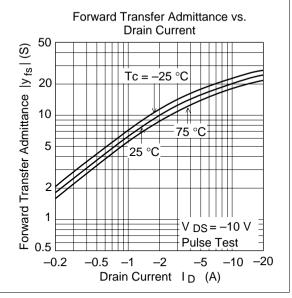
Main Characteristics

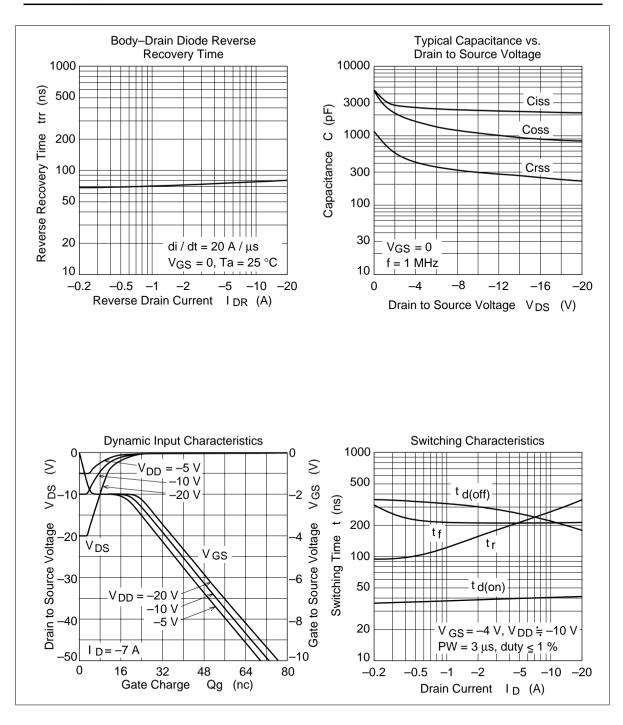


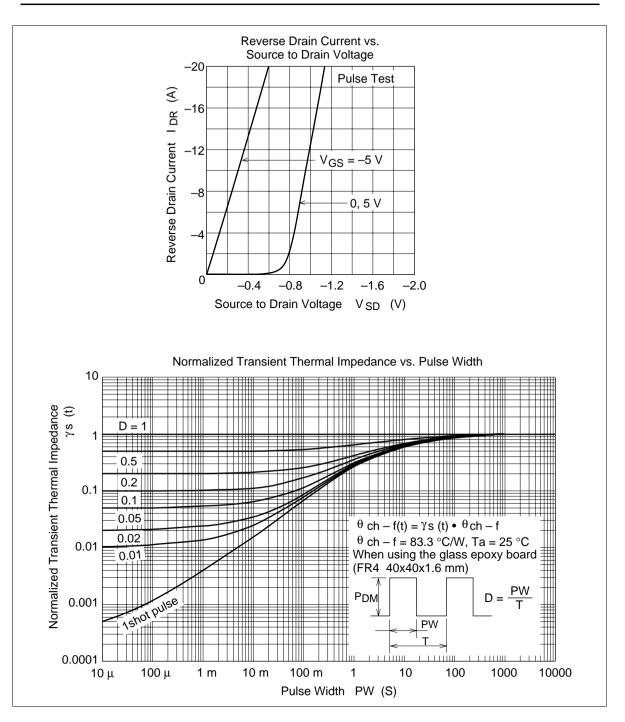


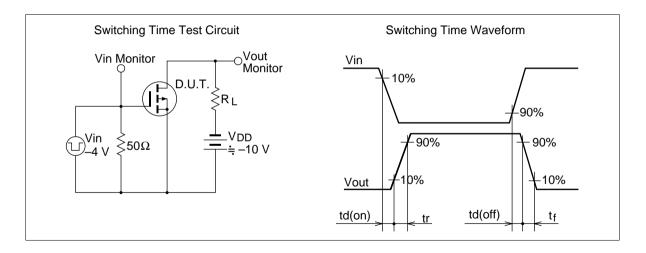






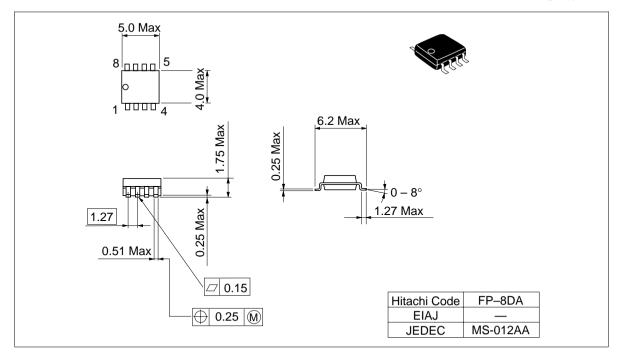






Package Dimensions

Unit: mm



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